TOSHIBA TA75060P

TOSHIBA BIPOLAR LINEAR INTEGRATED CIRCUIT SILICON MONOLITHIC

TA75060P

SINGLE OPERATIONAL AMPLIFIER

The TA75060P is a J-FET input low-power operational amplifier with low input bias and offset current, fast slew rate. The TA75060P is pin compatible with the TA7506P. The TA75060P is an excellent choice for active filters, integrators, buffers and sample-and-hold circuits.

FEATURES

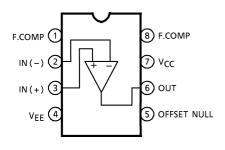
Low Supply Current : 250 μA MAX.
 Low Input Bias Current : 400pA MAX.
 Low Input Offset Current : 200pA MAX.
 High Slew Rate : 3.5V / μs (Ay = 1)

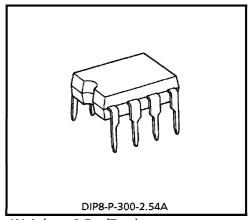
Wide Supply Voltage Range : ±2~±18V

Output Short Circuit Protection

Offset Null Capability

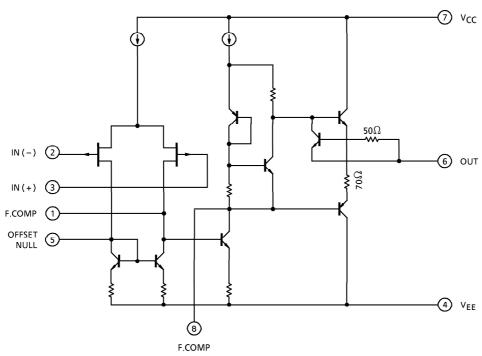
PIN CONNECTION (TOP VIEW)





Weight: 0.5g (Typ.)

EQUIVALENT CIRCUIT



MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	Vcc	18	V
Supply Voltage	VEE	– 18	V
Differential Input Voltage	DVIN	± 30	V
Input Voltage	V _{IN}	± 15	V
Power Dissipation	PD	500	mW
Operating Temperature	T _{opr}	- 40∼85	°C
Storage Temperature	T _{stg}	- 55∼125	°C

ELECTRICAL CHARACTERISTICS ($V_{CC} = 15V$, $V_{EE} = -15V$, Ta = 25°C)

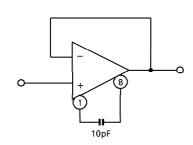
	<u>, cc , </u>						
CHARACTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Input Offset Voltage	V _{IO}	_	$R_g \le 10k\Omega$	_	3	15	mV
TC Of Input Offset Voltage	TCV _{IO}	_	_	_	10	_	μ V / °C
Input Offset Current	lιο	_	_	_	5	200	pА
Input Bias Current	IJ	_	_	_	30	400	pА
Common Mode Input Voltage	CMVIN	_	_	± 11.5	± 12	_	V
Maximum Output Voltage	Vом	_	$R_L = 10k\Omega$	20	27	_	V _{p-p}
Voltage Gain (Open Loop)	GV	_	$V_{OUT} = \pm 10V$, $R_L = 10k\Omega$	3	6	_	V/mV
Unity Gain Cross Frequency	f _T	_	Open Loop, $R_L = 10k\Omega$	_	1	_	MHz
Input Resistance	R _{IN}	_	_	_	10 ¹²	_	Ω
Common Mode Input Signal Rejection Ratio	CMRR	_	$R_g \le 10 k\Omega$	70	76	_	dB
Supply Voltage Rejection Ratio	SVRR	_	$R_g \le 10 k\Omega$	70	76	_	dB
Supply Current	ICC, IEE	_	Non load	_	200	250	μA

OPERATING CHARACTERISTICS ($V_{CC} = 15V$, $V_{EE} = -15V$, Ta = 25°C)

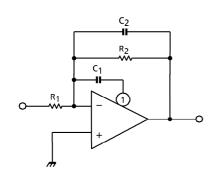
CHARACTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Slew Rate	SR	_	$V_{IN} = 10V_{p-p}, R_L = 10k\Omega,$ $C_L = 100pF, A_V = 1$	_	3.5	_	V / μ s
Equivalent Input Noise Voltage	V _{NI}	_	$R_S = 100\Omega$, $f = 1kHz$		42	_	nV /√Hz

TYPICAL APPLICATION

(1) UNITY-GAIN BUFFER



(3) FEED FORWARD COMPENSATION

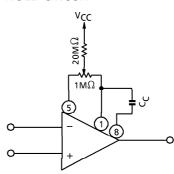


$$C_1 = 500 \text{pF}$$

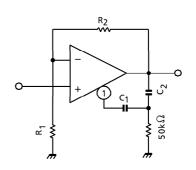
$$C_2 = \frac{1}{2\pi f_0 R_2}$$

$$f_0 \approx 1 \text{MHz}$$

(2) OFFSET NULL CIRCUIT



(4) TOW POLE COMPENSATION

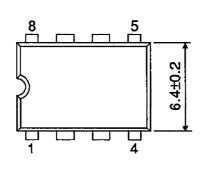


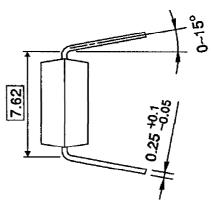
$$C_1 > \frac{C_1}{R_1 + R_2} C_S$$

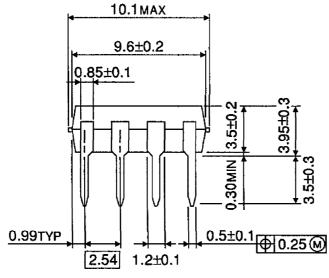
$$C_S = 10pF$$

$$C_2 = 10C_1$$

PACKAGE DIMENSIONS







Weight: 0.5g (Typ.)

RESTRICTIONS ON PRODUCT USE

000707EBA

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The products described in this document are subject to the foreign exchange and foreign trade laws.
- ◆ The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.

This datasheet has been download from:

www.datasheetcatalog.com

Datasheets for electronics components.